Notice	of References	s Cited
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Application/Control No. 10/551,039	Applicant(s)/Pa Reexamination FUJITA ET AL.			
Examiner	Art Unit			
JERRAH EDWARDS	3664	Page 1 of 1		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0002630 A1	01-2002	Nomura et al.	709/310
*	В	US-6,577,924 B1	06-2003	Kasuga et al.	700/245
*	С	US-2003/0191389 A1	10-2003	Sano et al.	600/437
*	D	US-2003/0192040 A1	10-2003	Vaughan, Robert D.	717/173
*	Е	US-2004/0009777 A1	01-2004	Koskimies et al.	455/456.1
*	F	US-2004/0002790 A1	01-2004	Senn, Paul	700/246
	G	US-		-	
	Н	US-			
	-	US-			
	J	US-			
	К	US-			
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	м	US-			

## FOREIGN PATENT DOCUMENTS

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## NON-PATENT DOCUMENTS

NON-PATENT DOCUMENTS		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Perlinent Pages)
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